## **ERB Series Specifications and Test Method (1)**

No.	Ite	Item Specifications		Test Method				
1	Operating Temperature Range -5		-55 to +125°C	Reference Temperature: 25°C				
2	2 Rated Voltage		See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor.  When AC voltage is superimposed on DC voltage, V <sup>p,p</sup> or V <sup>0</sup> whichever is larger, should be maintained within the rated voltage range.			ge, V <sup>P-P</sup> or V <sup>O-P</sup> ,	
3	Appearar	nce	No defects or abnormalities	Visual inspection				
4	Dimensio	ns	Within the specified dimension	Using calipers				
5	Dielectric Strength		No defects or abnormalities	No failure should be observed when 300%(*) of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.  (*) 300V: 250%, 500V: 200%			5 seconds,	
6	Insulation Resistance (I.R.)		1,000,000MΩ min. (C≦470pF) 100,000MΩ min. (C>470pF)	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and standard humidity and within 2 minutes of charging.				
7	Capacita	nce	Within the specified tolerance	The capacitance/Q s			at the	
8	Q		C≦ 220pF: Q≥10,000 220pF <c≦ 470pf:="" 5,000<br="" q≥="">470pF<c≦1,000pf: 3,000<br="" q≥="">C: Nominal Capacitance (pF)</c≦1,000pf:></c≦>	frequency and voltage shown in the table.  Frequency 1±0.1MHz  Voltage 1±0.2Vrms				
	Capacitance Temperature Characteristics	Capacitance Change	Within the specified tolerance (Table A-6)	capacitance measured in step 3 as a refer				
		Temperature Coefficient	Within the specified tolerance (Table A-6)	capacitance should l	ture sequentially from step 1 through 5, the should be within the specified tolerance for the coefficient and capacitance change as Table A.			
9		rature		The capacitance drift between the maximut, 3 and 5 by the capacitance.	e differences			
			Within ±0.2% or ±0.05pF	Step	Ter	mperature (°C	C)	
			Drift ('	(Whichever is larger)	1 2		25±2 -55±3	
						3		25±2
				4		125±3		
				5		25±2		
			No removal of the terminations or other defects should occur.		on the test jig	(glass epoxy	board) shown	
	Adhesive Strength of Termination		+C+ 	in Fig. 1 using an eutectic solder.  Then apply 10N* force in parallel with the test jig for 10±1sec.  The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.				
10			ion Janana	Туре	a	b	С	
				ERB18	1.0	3.0	1.2	
			Solder Resist  Baked Electrode or	ERB21 ERB32	1.2 2.2	4.0	1.65	
			Fig.1 Copper Foil	ERB32 2.2 5.0 2.9 (in mm) *5N (ERB188)				
			I					

Continued on the following page.  $\begin{tabular}{|c|c|c|c|} \hline \end{tabular}$ 



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No.	o. Item		s	pecifications	Test Method						
11		Appearance	No defects or abnormalities	es	Solder the capacitor to the test jig (glass epoxy boa			rd) in the			
		Capacitance	Within the specified tolera	nce	same manner and under the same conditions as (10).  The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).						
	Vibration Resistance	Q	Satisfies the initial value.  C≦ 220pF: Q≥1 220pF <c≦ (<="" 470pf:="" 470pf<c≦1,000pf:="" c:="" capacitance="" nominal="" q≥="" td=""><td>5,000 3,000</td></c≦>	5,000 3,000							
		Appearance	No marking defects								
		Capacitance	Within ±5% or ±0.5pF		1						
12		Change	(Whichever is larger)		Solder the capacitor on the test jig (glass epoxy board) s						
	Deflection		20 50 Pressuri speed:	in Fig. 2a using an eutectic solder. Then apply a force in the direction shown in Fig. 3a. The soldering should be done by the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.							
			Flexure : ≤1		Type ERB1		a 1.0				
					ERB2		1.0				
					ERB3		2.2				
			Capacitance meter 45 45	100							
			<del>  -</del>	t:1.6mm							
			Fig.3a	Fig. 2a	1						
13	Solderabi Terminati	derability of 95% of the terminations are to be soldered evenly and continuously.				Immerse the capacitor in a solution of isopropyl alcohol and rosin (25% rosin in weight proportion).  Preheat at 80 to 120°C for 10 to 30 seconds.  After preheating, immerse in an eutectic solder or Sn-3.0Ag-0.5Cu solder solution for 5±0.5 seconds at 245±5°C.					
			The measured and observe specifications in the follow	ved characteristics should satisfy the ving table.							
			Item	Specifications	Preheat accor	ding to the o	onditions	listed in the tab	le below.		
			Appearance	No marked defect	Immerse the capacitor in an eutectic solder or Sn-3.0Ag				.0Ag-0.5Cu		
			Capacitance	Within ±2.5% or ±0.25pF				5 seconds. Let	sit at room		
14	Resistand		Change	(Whichever is larger)	temperature fo	or 24±2 houi					
	to Soldering Heat		_	C≦ 220pF : Q≥10,000	Chip S			heat Condition			
			Q	220pF <c≦ 470pf="" 5,000<="" :="" q≥="" td=""><td>2.0×1.25mr</td><td></td><td></td><td></td><td></td></c≦>	2.0×1.25mr						
			Dielectric Strength	470pF <c≦1,000pf 3,000<br="" :="" q≥="">No failure</c≦1,000pf>	3.2×2.5mm	Eacn	Each 1 minute at 100 to 120°C and then 170 to 200°C				
				C: Nominal Capacitance (pF)							
			The measured and observ	ved characteristics should satisfy the							
			specifications in the follow	ring table.	Fix the capaci	tor to the cu	oportina ii	n in the same n	b c 3.0 1.2 4.0 1.65 5.0 2.9 (in mm)  sopropyl alcohol and conds. c solder std.5 seconds  ed in the table below. older or Sn-3.0Ag-0.5Cu seconds. Let sit at room  at Condition at 120 to 150°C 0.120°C and then 170 to 200°C  on the same manner and afform the five cycles ted in the following table. ture, then measure.  3 4 Max. Room		
			Item	Specifications	Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10). Perform the five cycles						
			Appearance	No marked defect							
			Capacitance	Within ±5% or ±0.5pF							
15	Temperat	ure	Change	(Whichever is larger)	Step	1	2	3	4		
	Cycle			C≧30pF : Q≧350		Min.		Max			
			Q	10pF≦C<30pF : Q≥275+5C C<10pF : Q≥200+10C	Temp. (°C)	Operating		Operating	Tomp		
			I.R.	C<10pr : Q≦200+10C 1,000MΩ min.		Temp. +0/-	.3	remp. +0/-3	<u> </u>		
			Dielectric Strength	No failure	Time (min.)	30±3	5 max	. 30±3	5 max.		
				C: Nominal Capacitance (pF)							
			1		1						

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No.	Item	S	pecifications	Test Method				
16	Humidity	The measured and observed characteristics should satisfy the specifications in the following table.		Apply the 24-hour heat (-10 to +65°C) and humidity (80 to 100%) treatment shown below, 10 consecutive times. Remove, let sit for 24±2 hours at room temperature, and measure.  C Humidity 80-98% Humidity 80-98% 90-				
17	High Temperature Load	The measured and obser specifications in the follow Item Appearance Capacitance Change Q I.R.	yed characteristics should satisfy the ying table.    Specifications	Apply 200% (500V only 150%) of the rated voltage for 1,000±12 hours at 125±3°C.  Remove and let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.				

## Table A-6

	Nominal Values	Capacitance Change from 25°C (%)					
Char.		<b>-</b> 55		<b>-</b> ;	30	-1	10
	(ppm/°C) Note 1	Max.	Min.	Max.	Min.	Max.	Min.
5C	0±30	0.58	-0.24	0.40	-0.17	0.25	-0.11

Note 1: Nominal values denote the temperature coefficient within a range of 25 to 125°C (for 5C)